

Thursday, 8 September

Oral Sessions

Date: Thursday, 08/Sept/2022

9:00am -	OS-09: ESD Location: G1	OS-13A: Computational electromagnetics Location: G2	OS-15: Automotive Location: G3
10:20am -	F-04A: Coffe break Location: Exhibition Area		
10:50am -	OS-10: Lightning Location: G1	OS-13B: Computational electromagnetics Location: G2	OS-16: Electric vehicles Location: G3
12:10pm -	L-04: Lunch break Location: Restaurant Area		
2:30pm -	OS-11: EMP Location: G1	OS-13C: Computational electromagnetics Location: G2	OS-17: EMC in automotive, aircraft and space applications Location: G3
3:50pm -	F-04B: Coffe break Location: Exhibition Area		
4:20pm -	OS-12: Advanced materials and harmonic distortion Location: G1	OS-14: Power Electronics Location: G2	OS-18: EMF, EMI and VSWR measurements Location: G3
5:40pm			

Session

OS-09: ESD

Time:

Location: G1

Thursday, 08/Sept/2022:

9:00am - 10:20am

Presentations

A fast and efficient Model Extraction Method to predict the Transient Response of ESD Protection Devices

François Ruffat¹, Fabrice Caignet¹, Alexandre Boyer¹, Fabien Escudié², Guillaume Mejezaze², Frédéric Puybaret²
¹LAAS-CNRS, France; ²CEA-Gramat, France

Wearable ESD Occurrence Rate Detection with Voltage Level Estimation

Gabriel Fellner¹, David Johannes Pommerenke^{1,2}, Seyed Mostafa Mousavi¹, Amin Pak^{1,2}, Matthias Wintersteller¹, Christoph Koger¹, Satyajeet Shinde³, Michael Hillstrom³
¹Graz University of Technology, Austria; ²SAL GEMC lab, Austria; ³Apple Inc., Cupertino, USA

Quantification of ESD Pulses Caused by Collision of Objects

Gabriel Fellner¹, Amin Pak^{1,2}, Seyed Mostafa Mousavi¹, Christoph Koger¹, Ali Khorrami³, David Pommerenke^{1,2}
¹Graz University of Technology, Austria; ²SAL, Austria; ³Apple Inc.

A Comparative Study on The Effects of PCB Traces, External Components and Hot-Plug Protection Architectures During DPI Simulations on BMS IC With a Predictive Analytical Model

Badr Guendouz^{1,3}, Kamel Abouda², Alexandre Boyer³, Sonia Ben Dhia³, Hiba Mediouni², Jérôme Dietsch⁴
¹BMS/EMC-ESD Team, NXP Semiconductors, France, LAAS-CNRS, Univ. de Toulouse, INSA, UPS, LAAS; ²BMS/EMC-ESD Teams, NXP Semiconductors, France; ³LAAS-CNRS, Univ. de Toulouse, INSA, UPS, LAAS; ⁴BMS/System Architecture team, NXP Semiconductors, France

Session

OS-13A: Computational electromagnetics

Time:

Location: G2

Thursday, 08/Sept/2022:

9:00am - 10:20am

Presentations

Conformal FDTD Simulation of Vibrating Intrinsic Reverberation Chambers

Florian MAHIDDINI, Guillaume ANDRIEU, Christophe GUIFFAUT, Nicolas BUI
XLIM, France

Exact-Kernel Thin-Wire MoM with Geometric Representation by Bézier Curves

Thomas Rylander¹, Matthys M. Botha²
¹Chalmers University of Technology, Sweden; ²Stellenbosch University

On the Decoupling of Integrals in the Surface PEEC Method

Maria De Lauretis¹, Elena Haller², Daniele Romano³, Giulio Antonini³, Jonas Ekman¹, Ivana Kovacevic-Badstubner⁴, Ulrike Grossner⁴
¹Luleå University of Technology, Sweden; ²Halmstad University, Sweden; ³University of L'Aquila, Italy; ⁴ETH Zurich, Switzerland

Suppression of Power-Bus Resonance and Unintentional Radiation by Lossy Resonator Filter

Sho Kanao, Shuhei Kodama, Kengo Iokibe, Yoshitaka Toyota
Okayama University, Japan

Session

OS-15: Automotive

Time:

Location: G3

Thursday, 08/Sept/2022:

9:00am - 10:20am

Presentations

Opportunities for Intentional Interference with Automotive Radars Using Commercial Sensors

Alastair Ruddle, Douglas Ruddle, Jaspal Singh, Richard Blachford
HORIBA MIRA Limited, United Kingdom

Analysis of the Power Coupling Between an Antenna and a Device Under Test in a MSRC to Replace On-board Immunity Tests of Automotive Equipment

BULE MBO Clovis^{1,2}, KLINGLER Marco¹, PICHON Lionel², BENSETTI Mohamed²

¹Stellantis, Centre technique de Vélizy, route de Gisy, 78943 Vélizy-Villacoublay; ²Université Paris-Saclay, CentraleSupélec, CNRS, Laboratoire de Génie Electrique et Electronique de Paris, 91192, Gif-sur-Yvette, France. Sorbonne Université, CNRS, Laboratoire de Génie Electrique et Electronique de Paris, 75252, Paris, France.

Analytical Method to Estimate Radiated Magnetic Field Emissions in Automotive Electric Drives

Madhavi Dhara, Guido A. Rasek
Valeo Siemens eAutomotive Germany GmbH, Germany

Integrated EMI Detector as Essential Safety Mechanism in Automotive Sensor Applications

Dieter Joos
onsemi, Belgium

Session

OS-10: Lightning

Time:

Location: G1

Thursday, 08/Sept/2022:

10:50am - 12:10pm

Presentations

Distribution of the current from lightning in Sweden

Rebecca Persson¹, Per Westerlund², Mahbubur Rahman¹, Milan Radosavljevic³, Stefan Ståhl⁴
¹Uppsala University; ²Luleå University of Technology; ³Svenska kraftnät; ⁴SMHI

Impact of IEMI pulses on a barometric sensor

Louis Cesbron Lavau¹, Michael Suhrke¹, Peter Knott^{2,3}
¹Fraunhofer INT, Germany; ²Fraunhofer FHR, Germany; ³RWTH Aachen, Germany

Effects of EMC filter topologies on the destruction scenarios of SMPS under high current interference pulses

Laurine CUROS^{1,2}, Guillaume MEJECAZE¹, Tristan DUBOIS², Frédéric PUYBARET¹, Jean-Michel VINASSA²
¹CEA, DAM, CEA-Gramat; ²Univ. Bordeaux, CNRS, Bordeaux INP, IMS UMR 5218

New Probe Design for Hardware Characterization by ElectroMagnetic Fault Injection

Clément Gaine¹, Driss Aboukassimi¹, Jean-Pierre Nikolovski¹, Jean-Max Dutertre²
¹Univ. Grenoble Alpes, CEA, LETI, MINATEC Campus, F-38054 Grenoble, France; ²Mines Saint-Etienne, CEA-Tech, Centre CMP, F-13541 Gardanne France

Session

OS-13B: Computational electromagnetics

Time:

Location: G2

Thursday, 08/Sept/2022:

10:50am - 12:10pm

Presentations

Co-simulation of Circuit/Circuit type Solvers for EMC Applications Using a New Relaxation Method

Amadou Bayaghiou DIALLO^{1,2}, Christian VOLLAIRE¹, Mohamed BENSETTI², Lionel PICHON², Arnaud BREARD¹

¹Univ Lyon, Ecole Centrale de Lyon, INSA Lyon, Université Claude Bernard Lyon 1, CNRS, Ampère, UMR 5005, Ecully, France; ²GeePs – Group of electrical engineering - Paris, UMR CNRS 8507, CentraleSupélec, Université Paris-Saclay, Sorbonne Université, 3 & 11 rue Joliot-Curie, Plateau de Moulon 91192 Gif-sur-Yvette, France

Measurement-Based Modeling of PCB-to-Coaxial Cable Transition for 3D Electromagnetic Simulation by Equivalent Circuit Assisted De-Embedding

Herbert Hackl¹, Bernhard Auinger¹, Mate Kovacs², Andreas Wagner², Christian Stockreiter²

¹Silicon Austria Labs GmbH, Austria; ²ams osram group, Austria

Density-based Topology Optimization for Conductor Pattern Design with Improved Impedance Boundary Condition

Katsuya Nomura

Kwansei Gakuin University, Japan

Accelerated Modal Network Synthesis for Arbitrary Interconnection Structures Through a Model-Order Reduction by a Static-Mode Extraction

Hannes Schreiber, Marco Leone

Otto-von-Guericke University Magdeburg, Germany

Session

OS-16: Electric vehicles

Time:

Location: G3

Thursday, 08/Sept/2022:

10:50am - 12:10pm

Presentations

Investigation of Ground Impedances effecting EMC during Charging Operations of Electric Vehicles

Inti Runa Supa Stölben¹, Jonas Bertelmann¹, Michael Beltle¹, Stefan Tenbohlen¹, Christian Bersch², Konstantin Spanos²

¹University of Stuttgart, Germany; ²Robert Bosch GmbH, Germany

Experimental Investigation on Magnetic Field Emissions of Wireless Power Transfer Vehicle Charging Systems

Sebastian Jeschke, Michael Kleinen, Marcel Olbrich, Jörg Bärenfänger

EMC Test NRW GmbH, Germany

Flexible Numerical Evaluation of Human Head Exposure to a Transmitter Coil For Wireless Power Transfer at 13.56 MHz

Hamideh Esmaeili, Cheng Yang, Christian Schuster

Hamburg University of Technology, Germany

Inverter Interference on Charging Communication System during 400 V DC Charging of Vehicle

Lennart Hasselgren¹, Georgios Mademlis², Åke Lindbeck², Oskar Dahl²

¹EMC Services, Sweden; ²Volvo Cars Corporation, Sweden

Session

OS-11: EMP

Time:

Location: G1

Thursday, 08/Sept/2022:

2:30pm - 3:50pm

Presentations

Uncertainty Propagation with an Asynchronous Temporal Co-simulation Method Applied to a Transmission Line Network

Imane Massaoudi, Pierre Bonnet

Université Clermont Auvergne, Clermont Auvergne INP, CNRS, Institut Pascal, France

Effectiveness of Radiofrequency Field Exposure Assessment for Vehicle Occupants Based on Empty Vehicle Field Data and Field Reference Levels

Alastair Ruddle

HORIBA MIRA Limited, United Kingdom

TEMPEST zoning for complex platforms

Frank Leferink^{1,2}, Chris Clemens³, Hans Bergsma¹

¹THALES, Hengelo, the Netherlands; ²University of Twente, Enschede, the Netherlands; ³Ministry of the Interior and Kingdom Relations Zoetermeer the Netherlands

Distance characteristics of field peak value of transient electric field caused by sphere-gap ESD using a optical E-field probe

Ken Kawamata¹, Shinobu Ishigami¹, Osamu Fujiwara²

¹Tohoku Gakuin University, Japan; ²Nagoya Institute of Technology, Japan

Session

OS-13C: Computational electromagnetics

Time:

Location: G2

Thursday, 08/Sept/2022:

2:30pm - 3:50pm

Presentations

Mixed Proper Orthogonal Decomposition with Harmonic Approximation for Parameterized Order Reduction of Electromagnetic Models

Riccardo Torchio¹, Alessandro Zanco², Francesco Lucchini³, Piergiorgio Alotto¹, Stefano Grivet-Talocia²

¹Università degli Studi di Padova, Dept. of Industrial Engineering; ²Politecnico di Torino, Dept. of Electronics and Telecommunications; ³Università degli Studi di Padova, Centro Ricerche Fusione

Modeling of a Litz Wire with Perfect Strand Pattern

Silvano Cruciani², Tommaso Campi¹, Francesca Maradei², Mauro Feliziani¹

¹University of L'Aquila, Italy; ²La Sapienza University of Rome, Italy

Numerical Simulation of Field Distribution Regarding Automotive Component EMC-testing According to ISO 11452-2

Andrea Hofer, Stefan Cecil

Seibersdorf Labor GmbH, Austria

Approach to S-band Antenna Pattern Distortion generated by Spacecraft Plasma Plume

Alessandro Giordani, Davide Morfei, Emiliano Scione, Emanuele Ruà

Thales Alenia Space italia s.p.a., Italy

Session

OS-17: EMC in automotive, aircraft and space applications

Time:

Location: G3

Thursday, 08/Sept/2022:

2:30pm - 3:50pm

Presentations

A Study on EMC Test Methods for ESD-Induced Conducted Noise through Space Structures

Toru KASAI¹, Toshio ONIGATA²

¹Japan Aerospace Exploration Agency: JAXA; ²e-OHTAMA, LTD.

Design of EMI Optimized Isolated DC/DC Converter for Space-based Applications

Patrick Koch, Johan Dijkstra, Niek Moonen

University of Twente, Netherlands, The

Radiated emissions from power feeders for electric propulsion in aircraft

Jesper Lansink Rotgerink

Royal Netherlands Aerospace Centre, Netherlands, The

Noise Source Modeling for Automotive Components Using a Wire-harness Bench

Noboru Maeda¹, Kengo Fukunaga¹, Keishi Miwa²

¹SOOKEN, INC.; ²Toyota Motor Corporation

Session

OS-12: Advanced materials and harmonic distortion

Time:

Location: G1

Thursday, 08/Sept/2022:

4:20pm - 5:40pm

Presentations

Predicting the EMI Induced Offset of a Differential Amplifier Stage using a Neural Network Model

Dominik Zupan, Daniel Kircher, Nikolaus Czepl

Graz University of Technology, Austria

Impact of Long Distribution Cable to the Harmonic Distortion in Indonesia Remote Microgrids

Ilman Sulaeman¹, Niek Moonen¹, Jelena Popovic^{1,2}, Frank Leferink^{1,3}

¹University of Twente, Enschede, the Netherlands; ²Klimop Energy, Deventer, the Netherlands; ³Thales Nederland B.V., Hengelo, the Netherlands

Broadband Effective Dielectric Permittivity of Heterogeneous 3D Printed PLA Structures

Marco A. Azpurua^{1,2}, Marc Mateu-Mateus¹, Marc Pous^{1,3}, Marcos Quilez¹, Ferran Silva¹

¹Universitat Politècnica de Catalunya, Spain; ²EMC Electromagnetic BCN, S.L. (EMC Barcelona), Spain; ³European Space Agency, the Netherlands

Radiation Reduction from Heatsinks by a PMC Surface

Muhammet Hilmi Nisanci¹, Francesco de Paulis²

¹Sakarya University, Turkey; ²University of L'Aquila, Italy

Session

OS-14: Power Electronics

Time:

Location: G2

Thursday, 08/Sept/2022:

4:20pm - 5:40pm

Presentations

Deep-Learning Based Transient Identification in Switched-Mode Power Supplies Conducted Emissions

Mattia Simonazzi¹, Leonardo Sandrolini¹, Marcello Iotti¹, Andrea Mariscotti²

¹University of Bologna, Italy; ²University of Genova, Italy

Impact of routing on the EMC behavior of a GaN HEMT-based full bridge DC-DC converter

Ayawo Roger EKON^{1,4}, Mickael PETIT^{1,3}, François COSTA^{1,2}, François BOUVET⁴, Eric DUPUY⁴

¹Université Paris-Saclay, ENS Paris-Saclay, CNRS, SATIE, 91190 Gif-sur-Yvette, France; ²Université Paris Est Créteil, INSPE, 94000 Créteil, France; ³Le CNAM, 75011 Paris, France; ⁴Synchrotron SOLEIL, 91190 Gif-sur-Yvette, France

Lumped Circuit Model for Concentrically Arranged Conductors in Power Electronic Systems

Daniel Seyfried¹, Bednarz Christian², Matthias Friedrich³

¹University of Applied Science Würzburg-Schweinfurt; ²Siemens Mobility GmbH; ³University of Applied Science Fulda

A Transfer Function Approach to Calculate the Radiation of a three-phase Inverter

Alexander Engeln, Kai-Uwe Rathjen, Eric Fritze, Klaus F. Hoffmann, Stefan Dickmann

Helmut Schmidt University Hamburg, Germany

Session

OS-18: EMF, EMI and VSWR measurements

Time:

Location: G3

Thursday, 08/Sept/2022:

4:20pm - 5:40pm

Presentations

Extending Site VSWR to Millimeter Wave using Cylindrical Mode Filtering

Zhong Chen¹, Phil Miller²

¹ETS-Lindgren, United States of America; ²RATLR, Inc., United States of America

Non-linear hybrid filter for the DC-side ripple current of voltage source converters

Sebastian Raab, Ansgar Ackva

University of Applied Sciences Wuerzburg-Schweinfurt, Germany

Assessment of EMI and Power Quality in Mains Power Distribution Using a Low-Cost Breakout Box for EMC Education

Cathrine E.S. Feloups^{1,3}, Niek Moonen¹, Frank Leferink^{1,2}

¹Electrical Engineering, Mathematics and Computer Science (EEMCS), University of Twente, Enschede, The Netherlands; ²Thales Netherlands, 7554 RR, Hengelo, The Netherlands; ³Department of Electrical Engineering, Faculty of Engineering, South Valley University, Qena, Egypt

Electromagnetic evaluation of UHF-RFID Smartshelf in Healthcare Environments

Pablo Marina¹, Samuel D. Suárez², Jose A. Hernández², Victor M. Febles², Luis E. Rabassa², Victoria Ramos¹

¹Instituto de Salud Carlos III; ²Hospital Universitario de Canarias